


<b>Search Notes</b> 	<b>Application/Control No.</b> 10822521	<b>Applicant(s)/Patent Under Reexamination</b> JURNG ET AL.
	<b>Examiner</b> Tai, Xiuyu	<b>Art Unit</b> 1795

SEARCHED			
Class	Subclass	Date	Examiner
422		10/15/2007	xt
423	447.3, 447.5, 447.7,445B	10/15/2007	xt
977		10/15/2007	xt

SEARCH NOTES			
Search Notes		Date	Examiner
Consulted Stuauteur Hendrickson		10/15/2007	xt
EAST, USPGPU, USPAT, USOCR, FPRS,EPT, JPO, DERWENT, IBM-TDB, Google		10/15/2007	xt

INTERFERENCE SEARCH			
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